



RF Exposure Evaluation

FOR

Shenzhen Onail Technology Co.,Ltd

Wireless Keyboard

Test Model: SUNX-BK

Prepared for : Shenzhen Onail Technology Co.,Ltd
Address : Room 1903&1905, Xingtong Building, No.88 Baoxing Road, Bao'an District Shenzhen Guangdong China

Prepared by : Shenzhen LCS Compliance Testing Laboratory Ltd
Address : 101, 201 Bldg A & 301 Bldg C, Juji Industrial Park Yabianxueziwei, Shajing Street, Baoan District, Shenzhen, 518000, China
Tel : (+86)755-82591330
Fax : (+86)755-82591332
Web : www.LCS-cert.com
Mail : webmaster@LCS-cert.com

Date of receipt of test sample : April 15, 2025
Number of tested samples : 2
Sample No. : A250207025-1, A250207025-2
Sample number : Prototype
Date of Test : April 15, 2025 ~ April 29, 2025
Date of Report : April 30, 2025



Shenzhen LCS Compliance Testing Laboratory Ltd.

Add: 101, 201 Bldg A & 301 Bldg C, Juji Industrial Park Yabianxueziwei, Shajing Street, Baoan District, Shenzhen, 518000, China

Tel: + (86) 0755-82591330 | E-mail: webmaster@lcs-cert.com | Web: www.lcs-cert.com

Scan code to check authenticity



RF Exposure Evaluation	
Report Reference No.	LCSA02105069EB
Date of Issue	April 30, 2025
Testing Laboratory Name.....	Shenzhen LCS Compliance Testing Laboratory Ltd.
Address	101, 201 Bldg A & 301 Bldg C, Juji Industrial Park Yabianxueziwei, Shajing Street, Baoan District, Shenzhen, 518000, China
Testing Location/ Procedure	Full application of Harmonised standards ■ Partial application of Harmonised standards □ Other standard testing method □
Applicant's Name	Shenzhen Onail Technology Co.,Ltd
Address	Room 1903&1905, Xingtong Building, No.88 Baoxing Road, Bao'an District Shenzhen Guangdong China
Test Specification	
Standard	FCC KDB publication 447498 D01 General 1 RF Exposure Guidance v06 FCC CFR 47 part1 1.1310 FCC CFR 47 part2 2.1093
Test Report Form No.	TRF-4-E-215 A/0
TRF Originator	Shenzhen LCS Compliance Testing Laboratory Ltd.
Master TRF	Dated 2011-03
Shenzhen LCS Compliance Testing Laboratory Ltd. All rights reserved. This publication may be reproduced in whole or in part for non-commercial purposes as long as the Shenzhen LCS Compliance Testing Laboratory Ltd. is acknowledged as copyright owner and source of the material. Shenzhen LCS Compliance Testing Laboratory Ltd. takes no responsibility for and will not assume liability for damages resulting from the reader's interpretation of the reproduced material due to its placement and context.	
Test Item Description. : Wireless Keyboard	
Trade Mark	N/A
Test Model	SUNX-BK
Ratings	Input: DC 5V, 1A DC 3.7V, 1000mAh by rechargeable battery
Result	Pass

Compiled by:

Nadia Zhou

Nadia Zhou/ Administrator

Supervised by:

Jack Liu

Jack Liu/ Technique principal

Approved by:

Gavin Liang

Gavin Liang/ Manager



Shenzhen LCS Compliance Testing Laboratory Ltd.

Add: 101, 201 Bldg A & 301 Bldg C, Juji Industrial Park Yabianxueziwei, Shajing Street, Baoan District, Shenzhen, 518000, China

Tel: +(86) 0755-82591330 | E-mail: webmaster@lcs-cert.com | Web: www.lcs-cert.com

Scan code to check authenticity



RF Exposure Evaluation

Test Report No. :	LCSA02105069EB	<u>April 30, 2025</u> Date of issue
--------------------------	-----------------------	--

Test Model.....	: SUNX-BK
EUT.....	: Wireless Keyboard
Applicant.....	: Shenzhen Onail Technology Co.,Ltd
Address.....	: Room 1903&1905, Xingtong Building, No.88 Baoxing Road, Bao'an District Shenzhen Guangdong China
Telephone.....	: /
Fax.....	: /
Manufacturer.....	: Shenzhen Onail Technology Co.,Ltd
Address.....	: Room 1903&1905, Xingtong Building, No.88 Baoxing Road, Bao'an District Shenzhen Guangdong China
Telephone.....	: /
Fax.....	: /
Factory.....	: Zhongshan Sunclean Co.,Ltd
Address.....	: F/2,F/5, F/6 #1, F/8 #2 ,Building G, NO.3 of Huanzhen North 13 RD, XinFeng Village Henglan Town, Zhongshan, Guangdong P.R. CHINA
Telephone.....	: /
Fax.....	: /

Test Result	Pass
--------------------	-------------

The test report merely corresponds to the test sample.

It is not permitted to copy extracts of these test result without the written permission of the test laboratory.



Shenzhen LCS Compliance Testing Laboratory Ltd.

Add: 101, 201 Bldg A & 301 Bldg C, Juji Industrial Park Yabianxueziwei, Shajing Street, Baoan District, Shenzhen, 518000, China

Tel: +(86) 0755-82591330 | E-mail: webmaster@lcs-cert.com | Web: www.lcs-cert.com

Scan code to check authenticity



Revision History

Report Version	Issue Date	Revision Content	Revised By
000	April 30, 2025	Initial Issue	--



Shenzhen LCS Compliance Testing Laboratory Ltd.
Add: 101, 201 Bldg A & 301 Bldg C, Juji Industrial Park Yabianxueziwei, Shajing Street, Baoan District, Shenzhen, 518000, China
Tel: +(86) 0755-82591330 | E-mail: webmaster@lcs-cert.com | Web: www.lcs-cert.com
Scan code to check authenticity



TABLE OF CONTENTS

Description	Page
1. PRODUCT INFORMATION	6
2.EVALUATION METHOD AND LIMIT	7
3. REFER EVALUATION METHOD	7
4. CONDUCTED POWER.....	8
5. EVALUATION RESULTS.....	8
6. CONCLUSION	8
7. DESCRIPTION OF TEST FACILITY	8
8. MEASUREMENT UNCERTAINTY	8





FCC RF Exposure Evaluation

1. Product Information

EUT	:	Wireless Keyboard
Test Model	:	SUNX-BK
Ratings	:	Input: DC 5V, 1A DC 3.7V, 1000mAh by rechargeable battery
Hardware Version	:	V1.0
Software Version	:	/
2.4G	:	
Frequency Range	:	2403MHz-2479MHz
Channel Number	:	3 channels
Modulation Type	:	GFSK
Antenna Description	:	PCB Antenna, 2.1dBi(Max.)
Exposure category	:	General population/uncontrolled environment
EUT Type	:	Production Unit
Device Type	:	Portable Device
Note: For a more detailed antenna description, please refer to the antenna specifications or the antenna report provided by the customer.		



Shenzhen LCS Compliance Testing Laboratory Ltd.

Add: 101, 201 Bldg A & 301 Bldg C, Juji Industrial Park Yabianxueziwei, Shajing Street, Baoan District, Shenzhen, 518000, China

Tel: +(86) 0755-82591330 | E-mail: webmaster@lcs-cert.com | Web: www.lcs-cert.com

Scan code to check authenticity



2. Evaluation method and Limit

According to KDB447498 D01 General RF Exposure Guidance v06 Section 4.3.1 Standalone SAR test exclusion considerations: "Unless specifically required by the published RF exposure KDB procedures, standalone 1-g head or body and 10-g extremity SAR evaluation for general population exposure conditions, by measurement or numerical simulation, is not required when the corresponding SAR Test Exclusion Threshold condition, listed below, is satisfied. These test exclusion conditions are based on source-based time-averaged maximum conducted output power of the RF channel requiring evaluation, adjusted for tune-up tolerance, and the minimum test separation distance required for the exposure conditions. The minimum test separation distance is determined by the smallest distance from the antenna and radiating structures or outer surface of the device, according to the host form factor, exposure conditions and platform requirements, to any part of the body or extremity of a user or bystander (see 5) of section 4.1). To qualify for SAR test exclusion, the test separation distances applied must be fully explained and justified by the operating configurations and exposure conditions of the transmitter and applicable host platform requirements, typically in the SAR measurement or SAR analysis report, according to the required published RF exposure KDB procedures. When no other RF exposure testing or reporting is required, a statement of justification and compliance must be included in the equipment approval, in lieu of the SAR report, to qualify for the SAR test exclusion. When required, the device specific conditions described in the other published RF exposure KDB procedures must be satisfied before applying these SAR test exclusion provisions; for example, handheld PTT two-way radios, handsets, laptops & tablets etc."

$$[(\text{max. power of channel, including tune-up tolerance, mW}) / (\text{min. test separation distance, mm})] \cdot [\sqrt{f} \text{ (GHz)}] \leq 3.0 \text{ for 1-g SAR and } \leq 7.5 \text{ for 10-g extremity SAR, where:}$$

- f (GHz) is the RF channel transmit frequency in GHz
- Power and distance are rounded to the nearest mW and mm before calculation
- The result is rounded to one decimal place for comparison
- 3.0 and 7.5 are referred to as the numeric thresholds in the step 2 below

The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm according to f) in section 4.1 is applied to determine SAR test exclusion.

When one of the following test exclusion conditions is satisfied for all combinations of simultaneous transmission configurations, further equipment approval is not required to incorporate transmitter modules in host devices that operate in the mixed mobile and portable host platform exposure conditions. The grantee is responsible for documenting this according to Class I permissive change requirements. Antennas that qualify for standalone SAR test exclusion must apply the estimated standalone SAR to determine simultaneous transmission test exclusion.

- a) The $[\sum \text{ of (the highest measured or estimated SAR for each standalone antenna configuration, adjusted for maximum tune-up tolerance) / 1.6 W/kg}] + [\sum \text{ of MPE ratios}] \leq 1.0$.
- b) The SAR to peak location separation ratios of all simultaneously transmitting antenna pairs operating in portable device exposure conditions are all ≤ 0.04 , and the $[\sum \text{ of MPE ratios}] \leq 1.0$.

3. Refer Evaluation Method

[ANSI C95.1-1999](#): IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz.

[FCC KDB publication 447498 D01 General 1 RF Exposure Guidance v06](#): Mobile and Portable Devices RF Exposure Procedures and Equipment Authorization Policies.

[FCC CFR 47 part1 1.1310](#): Radiofrequency radiation exposure limits.

[FCC CFR 47 part2 2.1093](#): Radiofrequency radiation exposure evaluation: portable devices



Shenzhen LCS Compliance Testing Laboratory Ltd.

Add: 101, 201 Bldg A & 301 Bldg C, Juji Industrial Park Yabianxueziwei, Shajing Street, Baoan District, Shenzhen, 518000, China

Tel: +(86) 0755-82591330 | E-mail: webmaster@lcs-cert.com | Web: www.lcs-cert.com

Scan code to check authenticity



4. Conducted Power Test Procedure

TX frequency range: 2479MHz

Device category: Portable device (Distance: 5mm) Max.

Field Strength: 91.38dBuV/m @3m

EIRP=E-104.8+20logD=91.38-104.8+20log3=-3.88dBm

Maximum Conducted Output Power: -3.88-2.1=-5.98dBm

Turn-up: -5±1

5. Evaluation Results

Band/Mode	Frequency (GHz)	Antenna Distance (mm)	RF output power		SAR Test Exclusion Threshold	SAR Test Exclusion
			dBm	mW		
GFSK	2.479	5	-4.0	0.3981	0.1254< 3.0	Yes

Remark:

1. Output power including tune up tolerance;

2. When the minimum test separation distance is < 5 mm, a distance of 5 mm according to f) in section 4.1 is applied to determine SAR test exclusion.

6. Conclusion

The measurement results comply with the FCC Limit per 47 CFR 2.1093 for the uncontrolled RF Exposure and SAR Exclusion Threshold per KDB 447498 v06.

7. Description of Test Facility

NVLAP Accreditation Code is 600167-0.

FCC Designation Number is CN5024

CAB identifier is CN0071.

CNAS Registration Number is L4595.

Test Firm Registration Number: 254912.

8. Measurement Uncertainty

Test Item		Frequency Range	Uncertainty	Note
Radiation Uncertainty	:	9KHz~30MHz	±3.10dB	(1)
		30MHz~200MHz	±2.96dB	(1)
		200MHz~1000MHz	±3.10dB	(1)
		1GHz~26.5GHz	±3.80dB	(1)
		26.5GHz~40GHz	±3.90dB	(1)
Conduction Uncertainty	:	150kHz~30MHz	±1.63dB	(1)
Power disturbance	:	30MHz~300MHz	±1.60dB	(1)
Occupied Channel Bandwidth	:	1GHz-40GHz	±5%	(1)

(1). This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

.....THE END OF REPORT.....



Shenzhen LCS Compliance Testing Laboratory Ltd.

Add: 101, 201 Bldg A & 301 Bldg C, Juji Industrial Park Yabianxueziwei, Shajing Street, Baoan District, Shenzhen, 518000, China

Tel: +(86) 0755-82591330 | E-mail: webmaster@lcs-cert.com | Web: www.lcs-cert.com

Scan code to check authenticity